



Scanning Electron Microscope (SEM) – 16 Marks



1. Introduction

- A **Scanning Electron Microscope (SEM)** is an advanced microscope that uses **electrons instead of light** to view the surface of very small objects.
 - It gives **high-resolution, 3D-like images** of a material's surface.
 - Mainly used in **research, material science, biology, and nanotechnology**.
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2. Working Principle

- SEM uses a **focused beam of high-energy electrons** to scan the surface of a sample.
 - When electrons hit the sample, they produce signals like:
 - **Secondary electrons**
 - **Backscattered electrons**
 - **X-rays**
 - These signals are collected to form a **detailed image** of the sample's surface structure.
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3. Construction / Parts

- **Electron Gun:** Produces the beam of electrons.
 - **Electromagnetic Lenses:** Focus the electron beam.
 - **Scanning Coils:** Move the beam in a scanning pattern.
 - **Sample Stage:** Holds the sample to be examined.
 - **Detector:** Detects secondary or backscattered electrons.
 - **Vacuum Chamber:** Maintains vacuum to avoid scattering of electrons.
 - **Display/Monitor:** Shows the magnified image.
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4. Steps in SEM Operation

1. Sample is placed inside the **vacuum chamber**.
 2. **Electron beam** is generated and focused on the sample.
 3. Beam **scans line by line** over the sample surface.
 4. **Electrons interact** with the sample and produce signals.
 5. Detectors collect these signals and convert them into an image.
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5. Properties / Characteristics

- Very high **magnification** (up to 1,000,000x).
- Excellent **depth of field** – 3D-like images.
- Works in a **vacuum**.

- Can detect **topography, composition, and morphology**.
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6. Applications

- **Material science** – surface cracks, coatings, metals.
 - **Biology** – cell surface and microorganism study.
 - **Semiconductor industry** – chip inspection.
 - **Forensics** – analyzing trace evidence.
 - **Nanotechnology** – viewing nanoparticles and nanostructures.
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7. Advantages

- **High resolution** and detail.
 - Can analyze **surface structure and composition**.
 - Works with a **variety of materials** (metals, polymers, biological samples).
 - Images can be stored and analyzed digitally.
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8. Disadvantages

- Expensive equipment.
 - Requires **vacuum** and **conductive samples** (non-conductors need coating).
 - Large and **not portable**.
 - Needs **skilled operator**.
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9. Future Scope

- Development of **mini SEMs** for field use.
 - Better detectors for **color SEM imaging**.
 - Integration with **AI for auto-analysis**.
 - **In-situ SEMs** – to observe reactions live inside the microscope.
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11. Summary

- **SEM** is a powerful microscope using **electrons** for **high-resolution imaging**.
 - Used to observe **fine surface details** of many types of materials.
 - Plays a vital role in **science, medicine, and industry**.
 - Continues to evolve with **modern technology** for better performance.
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